

MOSFET - Power, Single N-Channel

100 V, 65 mΩ, 13 A

NVTFS070N10MCL

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFWS070N10MCL Wettable Flanks Product
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltag	V_{DSS}	100	V		
Gate-to-Source Voltage	Э		V _{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	13	Α
Current R _{0JC} (Notes 1, 2, 3)	Steady	T _C = 100°C		9.0	
Power Dissipation	State	T _C = 25°C	P _D	25	W
R _{θJC} (Notes 1, 2)		T _C = 100°C		12	
Continuous Drain		T _A = 25°C	I _D	4.5	Α
Current R _{0JA} (Notes 1, 2, 3)	Steady	T _A = 100°C	1	3.2	
Power Dissipation	State	T _A = 25°C	P_{D}	2.9	W
R _{θJA} (Notes 1, 2)		T _A = 100°C	1	1.5	
Pulsed Drain Current	T _C = 25	°C, t _p = 10 μs	I _{DM}	47	Α
Operating Junction and Range	T _J , T _{stg}	-55 to +175	°C		
Single Pulse Drain-to-S Energy (I _{L(pk)} = 0.5 A)	E _{AS}	423	mJ		
Lead Temperature for S (1/8" from case for 10 s)	TL	260	°C		
Source Current (Body D	iode)		IS	19	Α

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

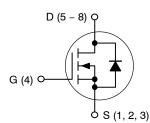
THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 2)	$R_{\theta JC}$	6.0	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	51	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
100 V	65 mΩ @ 10 V	13 A	
	90 mΩ @ 4.5 V	137	

N-Channel





WDFN8 (μ8FL) CASE 511AB



MARKING

DIAGRAM



WDFNW8 (u8FL WF) CASE 515AN



XXXXX = Specific Device Code
A = Assembly Location
Y = Year

WW = Work Week ■ Pb-Free Package

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

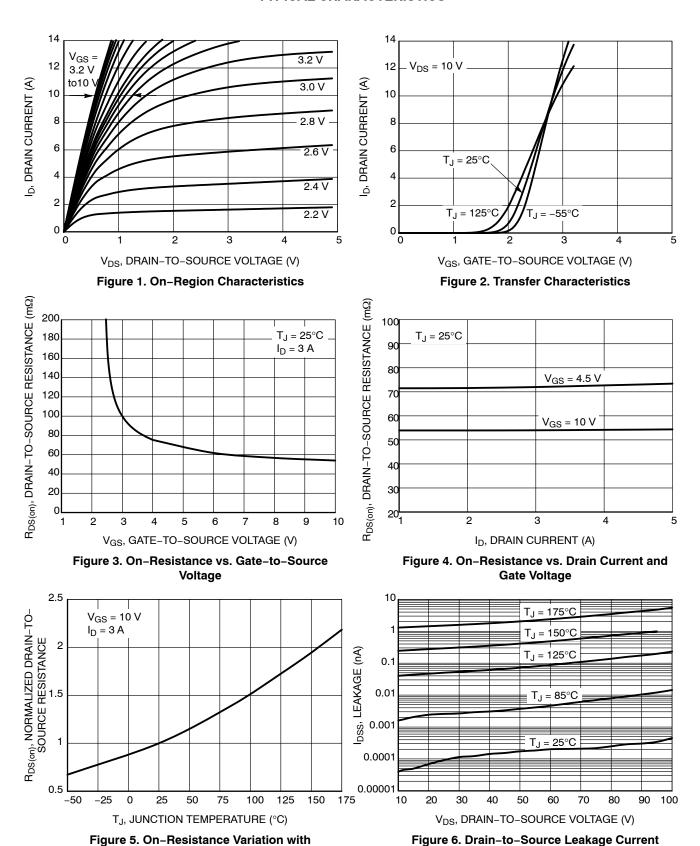
Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					1	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D =	250 μΑ	100			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				67		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	T _J = 25°C			1.0	
		$V_{DS} = 100 \text{ V}$	T _J = 125°C			100	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS}$	s = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= 15 μΑ	1.0		3.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 3 A		54	65	
		V _{GS} = 4.5 V	I _D = 2 A		72	90	mΩ
Forward Transconductance	9FS	V _{DS} = 10 V, I _I	_O = 3 A		11		S
CHARGES, CAPACITANCES & GATE RE	SISTANCE						
Input Capacitance	C _{ISS}				305		
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 50 V			135		pF
Reverse Transfer Capacitance	C _{RSS}				1.9		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 4.5 V, V _{DS} = 50 V; I _D = 2 A			2.7		
		V _{GS} = 10 V, V _{DS} = 50 V; I _D = 3 A		5.5		nC	
Threshold Gate Charge	Q _{G(TH)}				0.6		
Gate-to-Source Charge	Q_{GS}		-01/1 0.4		1.0		nC
Gate-to-Drain Charge	Q_{GD}	$V_{GS} = 10 \text{ V}, V_{DS} = 5$	00 V; I _D = 3 A		0.6		
Plateau Voltage	V_{GP}				2.6		V
SWITCHING CHARACTERISTICS (Note 5)						
Turn-On Delay Time	t _{d(ON)}				5.1		
Rise Time	t _r	$V_{GS} = 10 \text{ V}, V_{DS}$	s = 50 V,		1.3		1
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = 10 \text{ V}, V_{DS}$ $I_{D} = 3 \text{ A}, R_{G}$	= 6 Ω		12.1		ns
Fall Time	t _f				2.8		1
DRAIN-SOURCE DIODE CHARACTERIS	TICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 \text{ V}, I_{S} = 3 \text{ A}$, T _J = 25°C		0.84	1.3	V
		V _{GS} = 0 V, I _S = 3 A	T _J = 125°C		0.72		
Reverse Recovery Time	t _{RR}				19		ns
Reverse Recovery Charge	Q _{RR}	VGS = 0 V, di/dt =	100 A/μs,		8		nC
Charge Time	t _S	I _S = 1 A			9		
Discharge Time	t _D				10		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



vs. Voltage

Temperature

TYPICAL CHARACTERISTICS

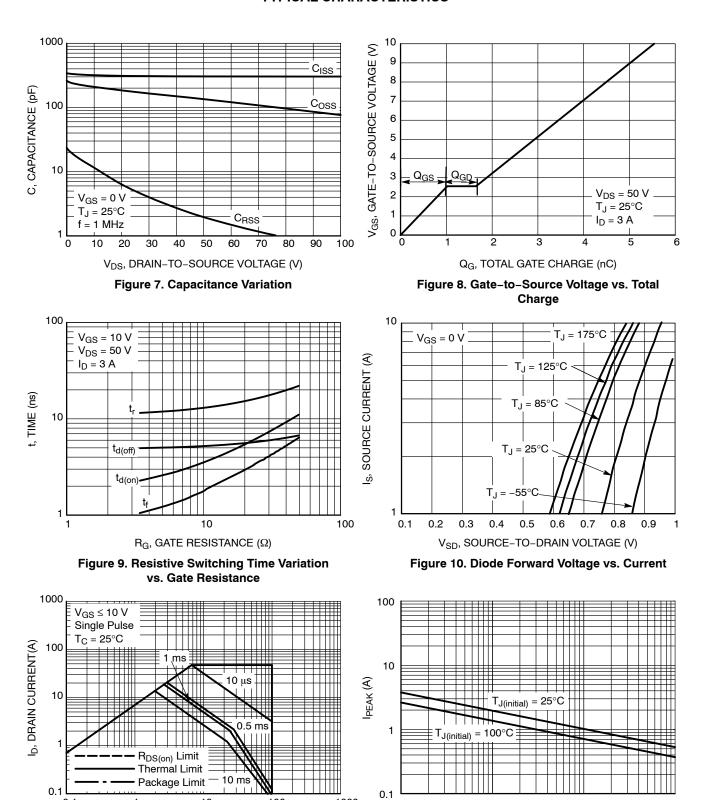


Figure 11. Maximum Rated Forward Biased Safe Operating Area

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

10

100

0.1

TIME IN AVALANCHE (s) Figure 12. I_{PEAK} vs. Time in Avalanche

0.001

0.0

0.0001

1000

0.00001

TYPICAL CHARACTERISTICS

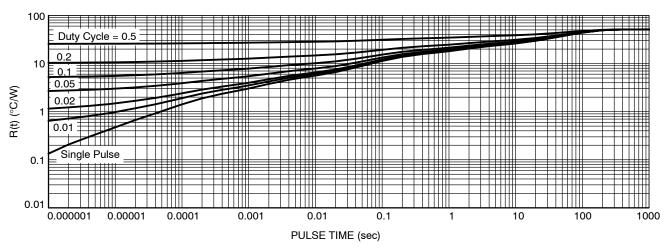


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVTFS070N10MCLTAG	70L1	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFWS070N10MCLTAG	70W1	WDFN8 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

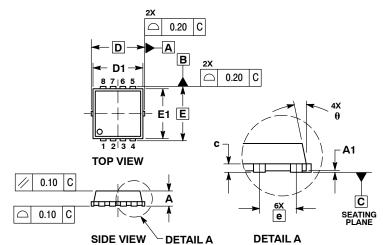
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

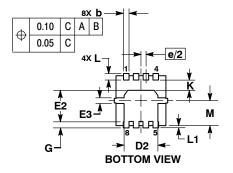
DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
С	0.15	0.20	0.25	0.006	0.008	0.010	
D		3.30 BSC		0	.130 BSC		
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E	3.30 BSC			0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е		0.65 BSC	;	0.026 BSC			
G	0.30	0.41	0.51	0.012	0.016	0.020	
K	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
M	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

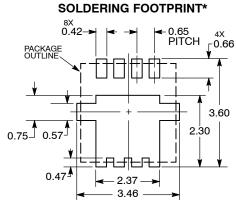


GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code Α = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

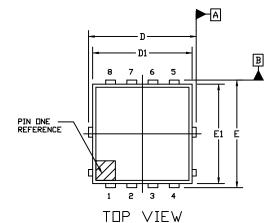
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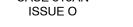
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^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

WDFNW8 3.3x3.3, 0.65P (Full-Cut μ8FL WF) CASE 515AN **ISSUE O**

DATE 25 AUG 2020



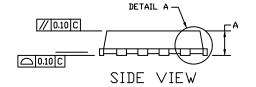


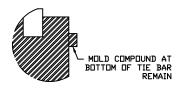
NOTES:

- 1. DIMENSIONING AND TOLERANCING PERASME Y14.5M, 2009.
- CONTROLLING DIMENSION MILLIMETERS
- DIMENSION DI AND EI DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.

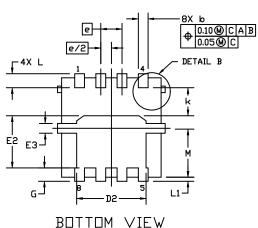
		<	ATED	AREA
A1	DETAIL	Т А	C SEATI PLANE	

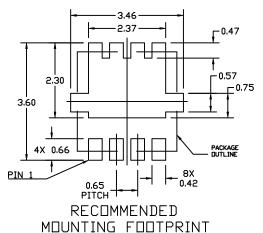
	MILLIMETERS				
DIM	MIN.	NDM.	MAX.		
Α	0.70	0.75	0.80		
A1	0.00		0.05		
b	0.23	0.30	0.40		
c	0.15	0.20	0.25		
D	3.05	3.30	3.55		
D1	2.95	3.05	3.15		
D2	1.98	2.11	2.24		
Ε	3.05	3.30	3.55		
E1	2.95	3.05	3.15		
E2	1.47	1.60	1.73		
E3	0.23	0.30	0.40		
e		0.65 BSC			
G	0.30	0.41	0.51		
K	0.65	0.80	0.95		
L	0.30	0.43	0.59		
L1	0.06	0.13	0.20		
М	1.40	1.50	1.60		





DETAIL B





For additional information on our Pb-Free strategy and soldering details, please download the IN Semiconductor Soldering and Mounting Techniques Reference Manual, SDLDERRM/D.

GENERIC MARKING DIAGRAM*

XXXX AYWW= XXXX = Specific Device Code

= Assembly Location

= Year

WW = Work Week

= Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "=", may or may not be present. Some products may not follow the Generic Marking.

(Note: Microdot may be in either location)

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